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### Texas Instruments High Rel Products Reliability Report

Device Type/Device Family: ADS1282SJDJ

Package Type: 28 JDJ

Wafer Fabrication Facility: Ti DMOS5

Assembly/Test Facility: Millennium Microtech

Reporting Period: 04/12

### **Biased Life Test**

Test Method: JESD22-A108 Test Condition: 205°C / 1000 hours

Sample Size: 180 Rejects: 0

Activation Energy (eV): .5
Equivalent Device Hours: 180000
Failure Rate (FIT)\*: 5123

<sup>\* 60%</sup> confidence level of random failure rate during nominal 1000 hour life based on test sample size. This not based on wear out failure mechanisms which will begin to affect above the 1000 hr test limit.

| Description                                 | Group B Tests (Wee<br>Condition | kly by Package Family)<br>Referenced Method | Sample Size/Beieste |   |  |
|---|---------------------------------|---|---------------------|---|--|
| Description<br>B1                           | Condition                       | Referenced Method                           | Sample Size/Rejects |   |  |
| Resistance to                               |                                 | Mil Std 883                                 | 3/0                 |   |  |
| Solvents<br>B2                              |                                 | Method 2015                                 |                     | * |  |
| Bond strength                               | Test condition F (FC)           | Mil Std 883                                 | 22/0-3/0            | * |  |
|   |                                 | Method                                      |                     |   |  |
|   |                                 | 2011/2019/2027                              |                     |   |  |
| B3  |                                 |   |                     |   |  |
| Solderability                               | Soldering temperature           | Mil Std 883                                 | 22/0                |   |  |
|   | of 245C±5                       | Method 2003                                 |                     |   |  |
| Group C Test (Per 3 Month Period by Family) |                                 |   |                     |   |  |
| Description<br>C1                           | Condition                       | Referenced Method                           | Sample Size/Rejects |   |  |
| Steady-state life test                      | 125C/1000Hrs<br>4.6V            | Mil Std 883<br>Method 1005                  |                     |   |  |
| End point electrical                        | 4.0 V                           | Method 1003                                 | 45/0                | * |  |

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| Description<br>D1          | Group D Tests (Ann<br>Condition | nually by Package Family)<br>Referenced Method | Sample Size/Rejects |   |
|----------------------------|---------------------------------|--|---------------------|---|
| Physical Dimensions        |                                 | Mil Std 883<br>Method 2016                     | 15/0                | * |
| D2<br>Lead Integrity       |                                 | Mil Std 883<br>Method 2004 & 2028              | 45/0                | * |
| Seal(Fine and Gross)       |                                 | Mil Std 883<br>Method 1014                     | 45/0                | * |
| D3                         |                                 | Wiction 1014                                   |                     |   |
| Thermal Shock              | -65°C to +150°C<br>15 cycles    | Mil Std 883<br>Method 1011                     |                     |   |
| Temperature Cycle          | -65°C to +150°C<br>100 cycles   | Mil Std 883<br>Method 1010                     |                     | * |
| Moisture Resistance        | •                               | Mil Std 883<br>Method 1004                     |                     |   |
| Seal(Fine and Gross)       |                                 | Mil Std 883                                    |                     | * |
| Visual examination         |                                 | Method 1014<br>Mil Std 883                     |                     |   |
| Visual examination         |                                 | Method 1004 &1010                              |                     |   |
| End point electrical<br>D4 |                                 |  | 15/0                | * |
| Mechanical Shock           |                                 | Mil Std 883                                    |                     |   |
| Variable Freq              |                                 | Method 2002<br>Mil Std 883                     |                     | * |
| Variable Freq              |                                 | Method 2007                                    |                     |   |
| Constant acceleration      |                                 | Mil Std 883                                    |                     |   |
| 0 1                        |                                 | Method 2001                                    |                     | * |
| Seal                       |                                 | Mil Std 883<br>Method 1014                     |                     | ^ |
| Visual Examination         |                                 | Mil Std 883                                    |                     |   |
|                            |                                 | Method 2009                                    |                     |   |
| End point electrical<br>D5 |                                 |  | 15/0                | * |
| Salt Atmosphere            |                                 | Mil Std 883                                    |                     |   |
| Cool                       |                                 | Method1009                                     |                     | * |
| Seal                       |                                 | Mil Std 883<br>Method 1014                     |                     |   |
| Visual Examination         |                                 | Mil Std 883                                    | 15/0                |   |
|                            |                                 | Method 1009                                    |                     |   |
| D6                         |                                 |  |                     |   |
| Internal Water Vapor       |                                 | Mil Std 883<br>Method1018                      | 3/0                 |   |
| D7                         |                                 |  |                     |   |
| Adhesion of Lead           |                                 | Mil Std 883                                    | 15/0                |   |
| Finish                     |                                 | Method 2025                                    |                     |   |

## Supplemental Device Characteristics

Die Revision: С Assembly Site: MMT Package Type: **CDIP** Master Die: CADS1282CANPH Wafer Fab: DMOS5 Pin Count: 28 Fab Technology: 50HPA07 Mold Compound: Ceramic Fab Process: HPA07 Mount Compound: JM7000 Process Code: N/A Bond: ΑI Passivation: 8K\_OXN\_A Lead Composition: Kovar Lead Finish: Au

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